



Control Carrier Trapping-Detrapping Events: Pioneering Memory-Transistor Functionalities in van der Waals Electronics

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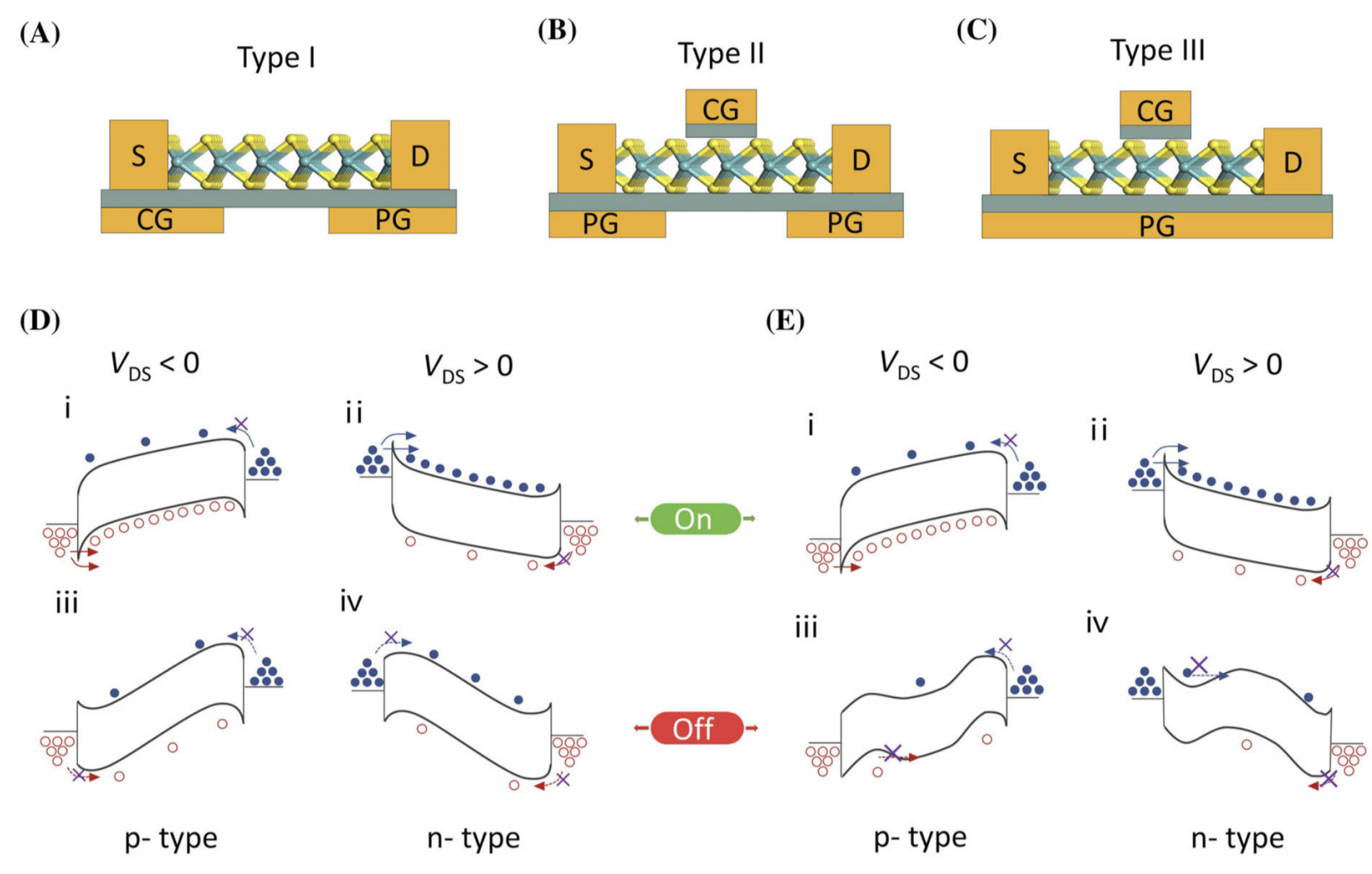


Motivation and operation concepts

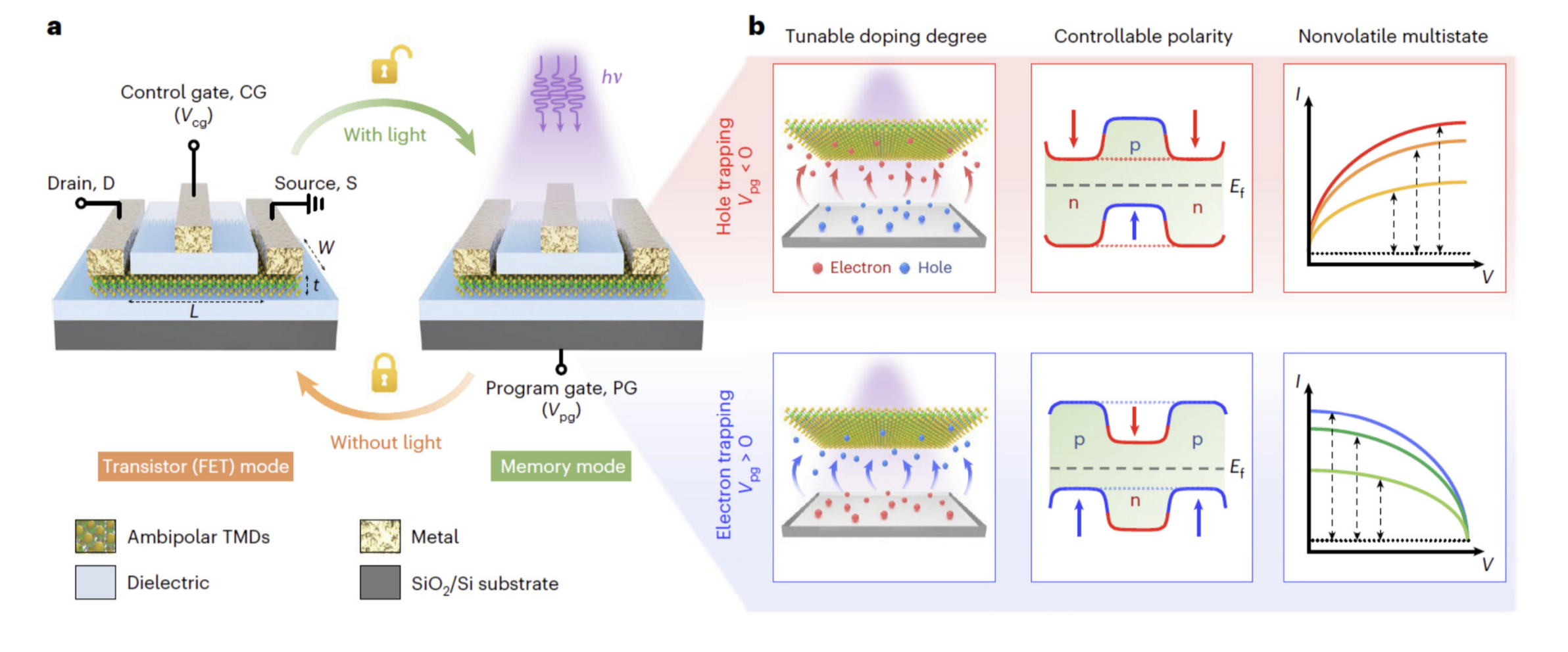
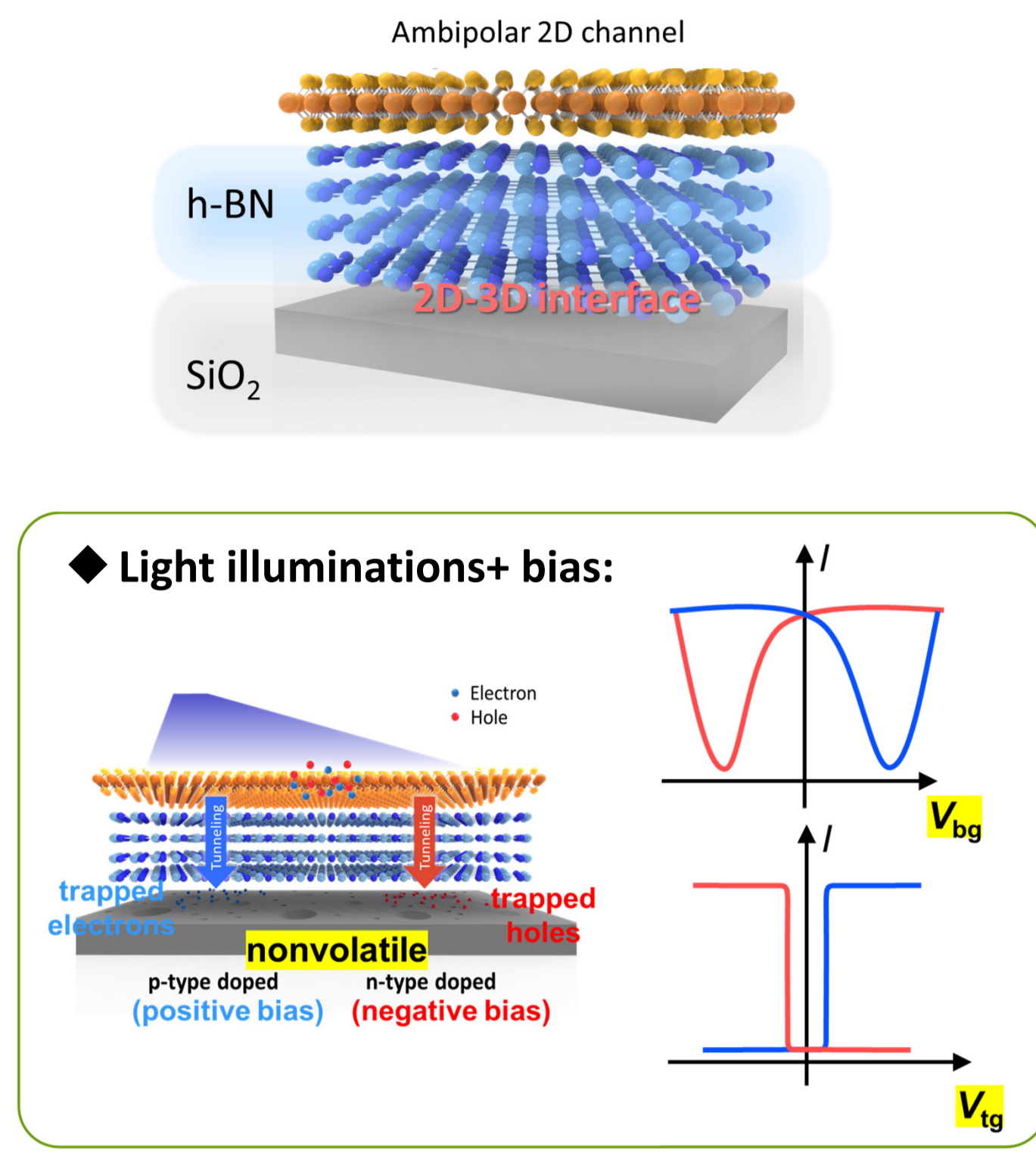


Nat. Electron. 6, 755 (2023); Sci. Adv. 9, eadk1597 (2023)

Reconfigurable field-effect transistors (RFETs)

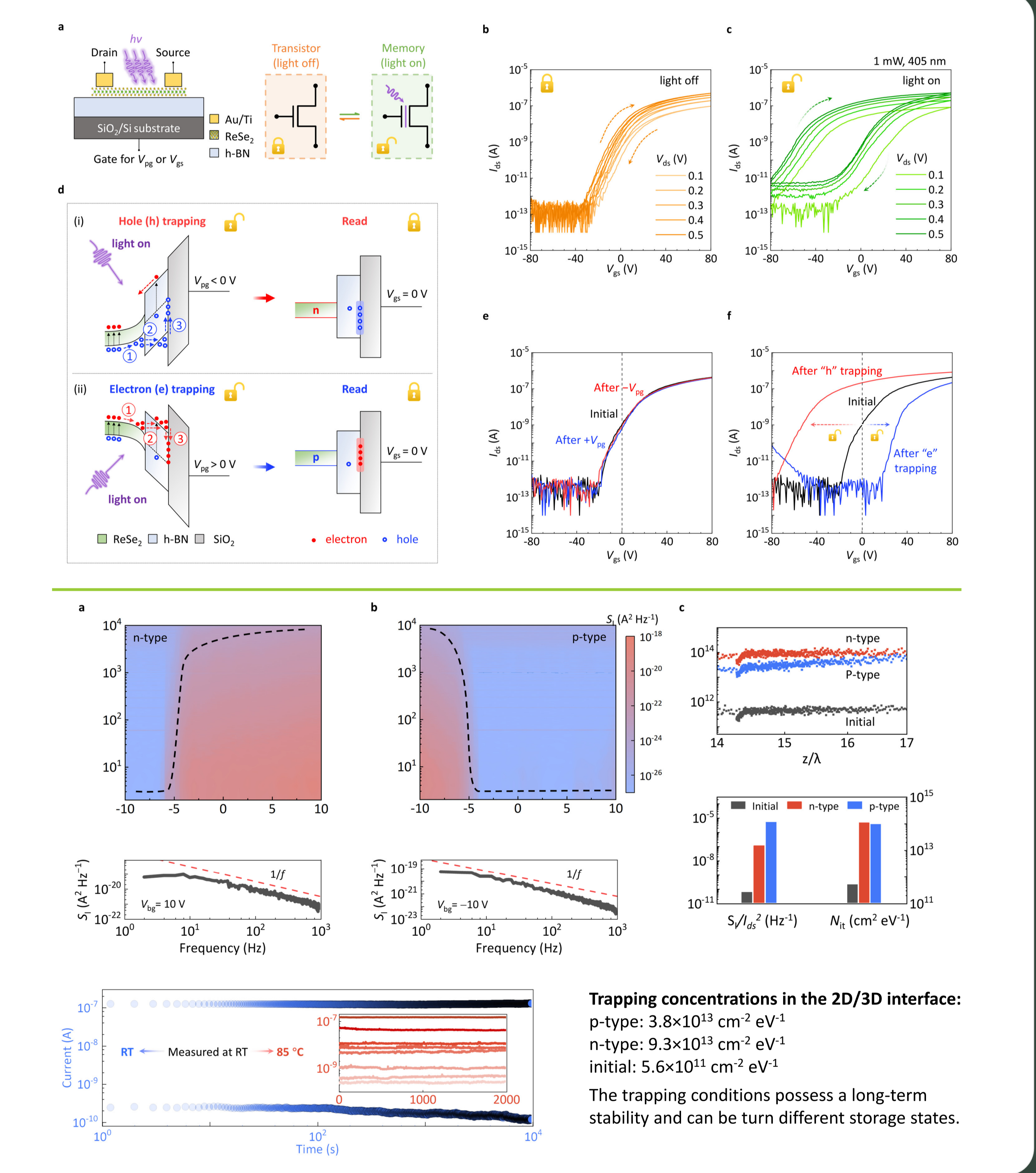


Fei, W., et al. (2022). "Emerging reconfigurable electronic devices based on two-dimensional materials: A review." *InfoMat.* 4, e12355

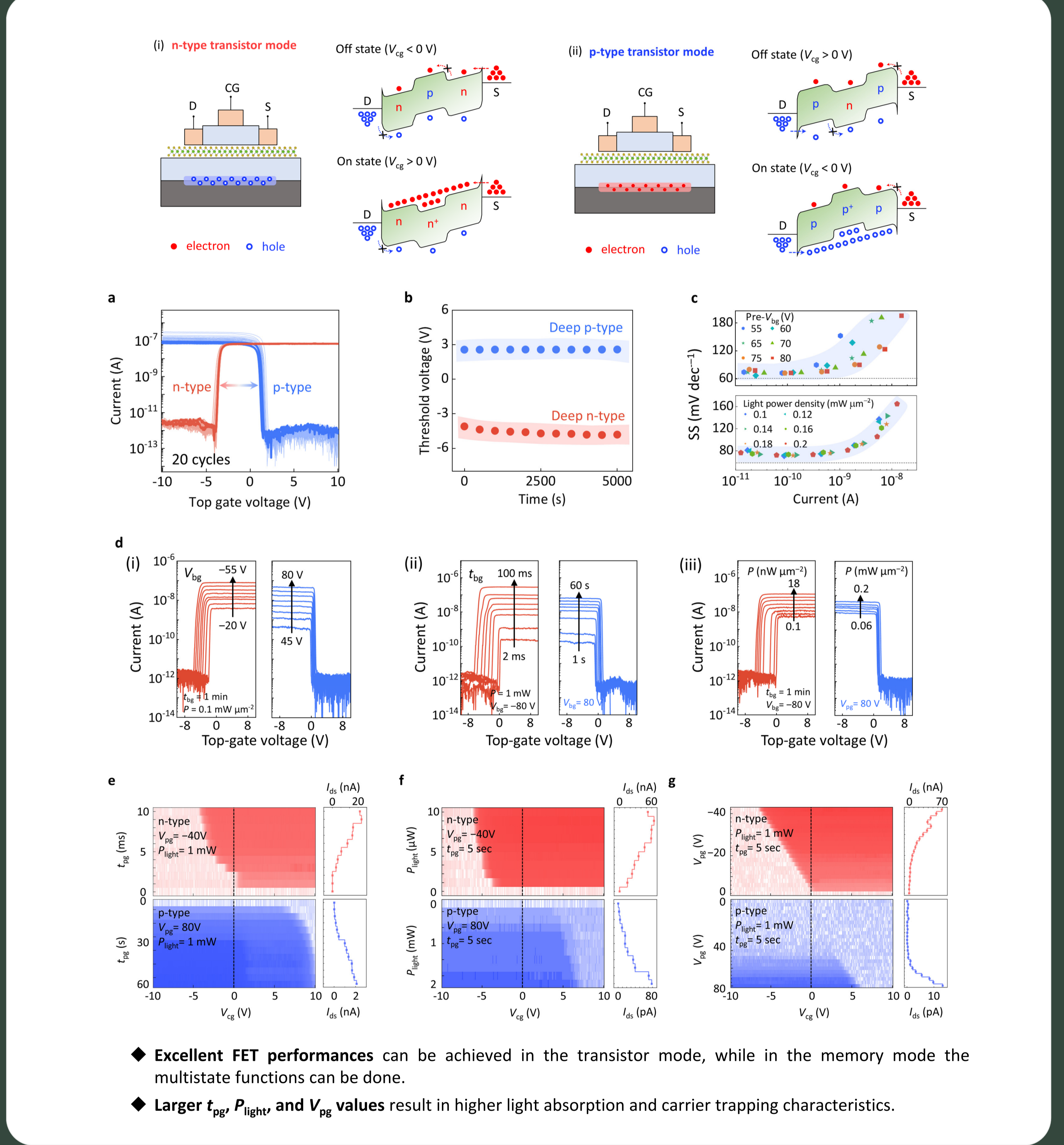


a, Schematic illustrations of the proposed PT-RFET heterostructure device. Light illumination acts as a switching key between the transistor mode and the memory mode. b, Illustrations of the tunable doping degree, n/p polarity control, and the nonvolatile multistate characteristics that can be realized in the proposed photoinduced trapping RFETs. Here, E_f represents the Fermi level.

Nonvolatile photoinduced trapping



Demonstration of device operations



◆ Excellent FET performances can be achieved in the transistor mode, while in the memory mode the multistate functions can be done.
◆ Larger t_{tr} , P_{light} and V_{pg} values result in higher light absorption and carrier trapping characteristics.

Demonstration of reconfigurable transistor-memory functions

